

TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL PLANAR TYPE

2SC4842

VHF~UHF BAND LOW NOISE AMPLIFIER APPLICATIONS.

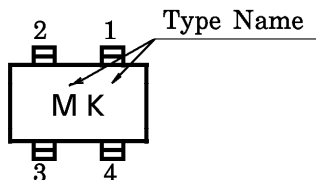
Unit in mm

- Low Noise Figure, High Gain.
- $NF = 1.1\text{dB}$, $|S_{21e}|^2 = 14\text{dB}$ ($f = 1\text{GHz}$)

MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	V_{CBO}	20	V
Collector-Emitter Voltage	V_{CEO}	12	V
Emitter-Base Voltage	V_{EBO}	3	V
Collector Current	I_C	80	mA
Base Current	I_B	40	mA
Collector Power Dissipation	P_C	100	mW
Junction Temperature	T_j	125	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	$-55 \sim 125$	$^\circ\text{C}$

Marking



		1, 3. EMITTER
		2. BASE
		4. COLLECTOR
JEDEC	—	
EIAJ	—	
TOSHIBA	2-2K1A	

Weight : 0.006g

MICROWAVE CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Transition Frequency	f_T	$V_{CE} = 10\text{V}$, $I_C = 20\text{mA}$	5	7	—	GHz
Insertion Gain	$ S_{21e} ^2 (1)$	$V_{CE} = 10\text{V}$, $I_C = 20\text{mA}$, $f = 500\text{MHz}$	—	19.5	—	dB
	$ S_{21e} ^2 (2)$	$V_{CE} = 10\text{V}$, $I_C = 20\text{mA}$, $f = 1\text{GHz}$	10.5	14	—	
Noise Figure	NF (1)	$V_{CE} = 10\text{V}$, $I_C = 5\text{mA}$, $f = 500\text{MHz}$	—	1	—	dB
	NF (2)	$V_{CE} = 10\text{V}$, $I_C = 5\text{mA}$, $f = 1\text{GHz}$	—	1.1	2	

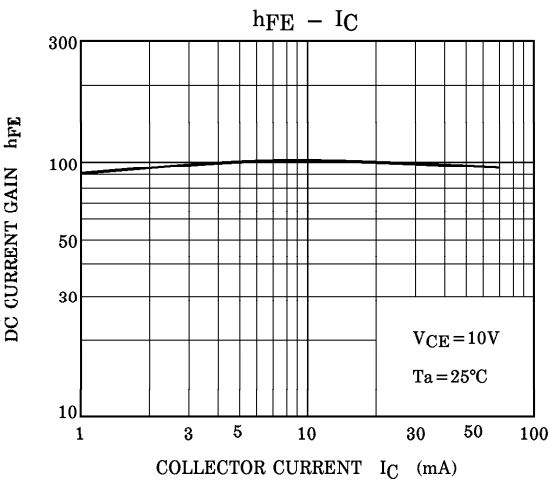
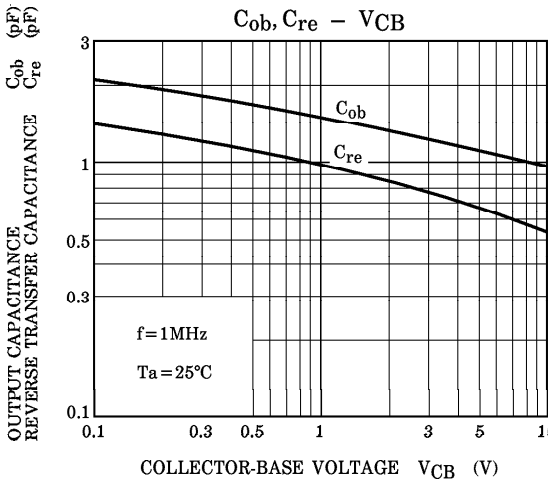
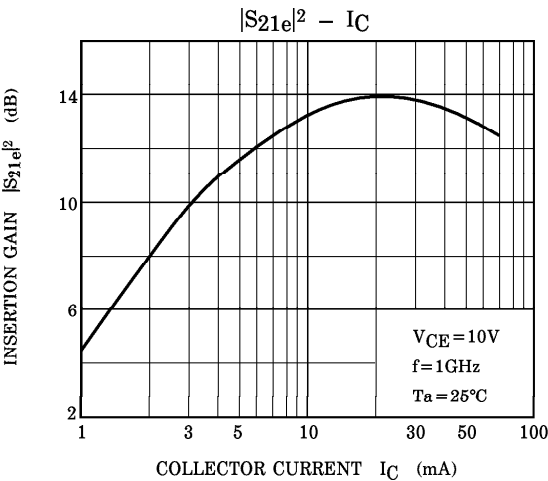
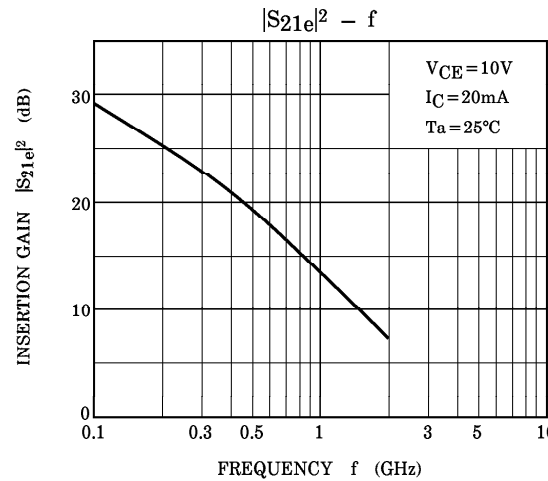
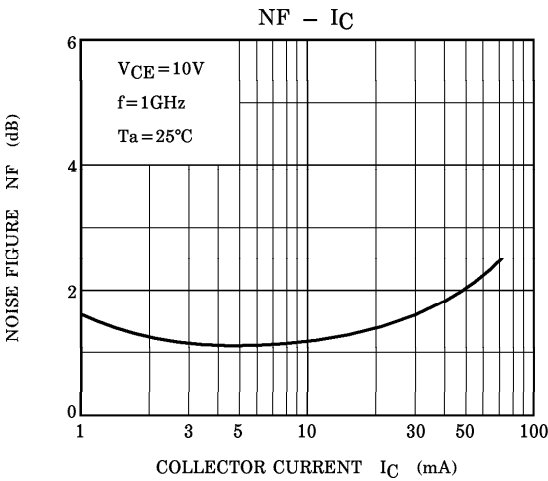
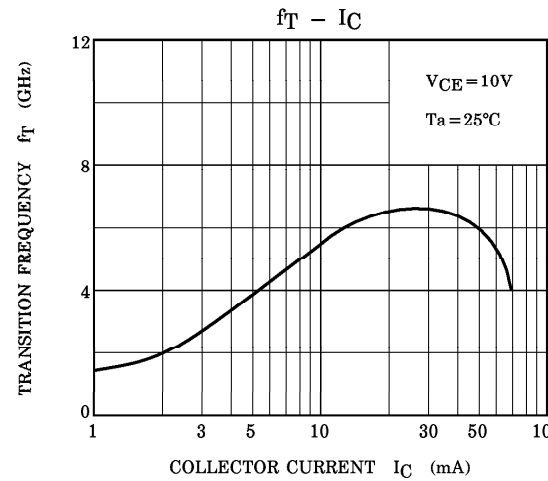
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	I_{CBO}	$V_{CB} = 10\text{V}$, $I_E = 0$	—	—	1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 1\text{V}$, $I_C = 0$	—	—	1	μA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}$, $I_C = 20\text{mA}$	30	—	250	—
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}$, $I_E = 0$, $f = 1\text{MHz}$	—	0.8	—	pF
Reverse Transfer Capacitance	C_{re}	(Note)	—	0.55	1	pF

Note : C_{re} is measured by 3 terminal method with capacitance bridge.

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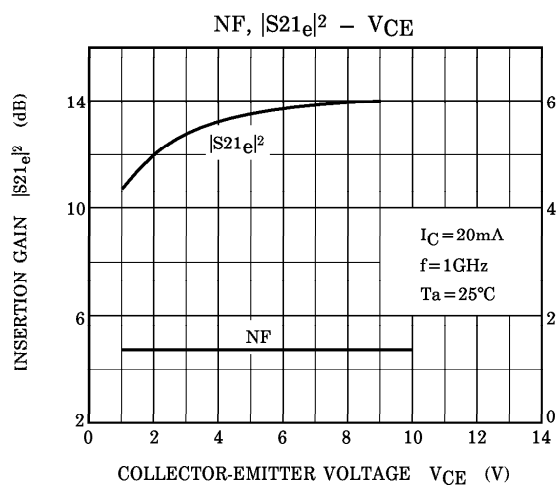
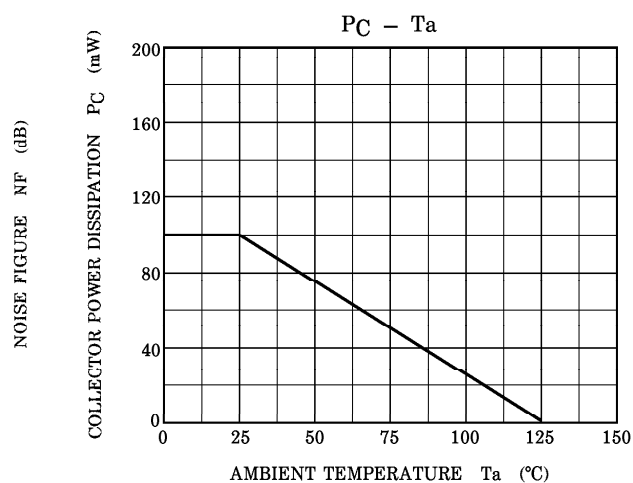
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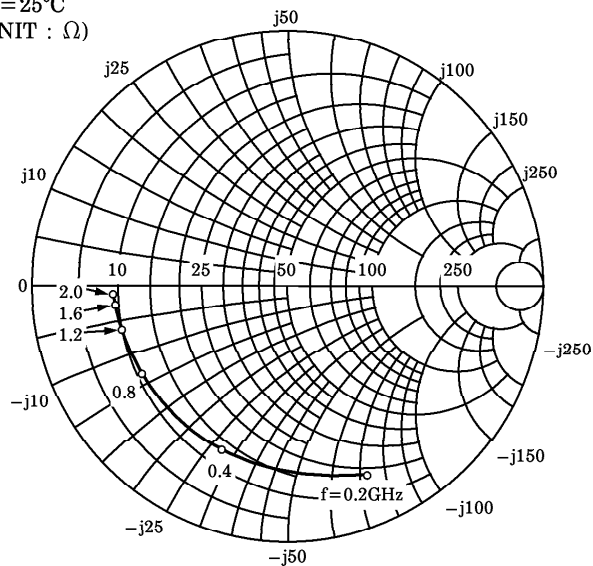
S-PARAMETER $Z_0 = 50\Omega$, $T_a = 25^\circ\text{C}$
 $V_{CE} = 10\text{V}$, $I_C = 5\text{mA}$

FREQUENCY		S11		S21		S12		S22	
MHz	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG	
200	0.794	−68.9	10.322	137.8	0.048	54.1	0.798	−29.8	
400	0.722	−112.7	7.453	114.8	0.065	38.7	0.599	−41.1	
600	0.699	−136.4	5.534	101.5	0.070	33.4	0.500	−45.9	
800	0.683	−150.6	4.321	92.9	0.072	32.5	0.450	−49.3	
1000	0.678	−160.9	3.499	86.1	0.073	33.7	0.425	−53.1	
1200	0.680	−168.2	2.967	81.2	0.073	36.5	0.412	−57.1	
1400	0.688	−173.8	2.584	76.5	0.074	40.7	0.408	−61.5	
1600	0.692	−178.4	2.291	72.6	0.075	45.7	0.406	−66.2	
1800	0.702	−177.5	2.071	68.8	0.078	50.8	0.409	−70.6	
2000	0.709	−173.7	1.902	64.9	0.082	56.0	0.416	−75.4	

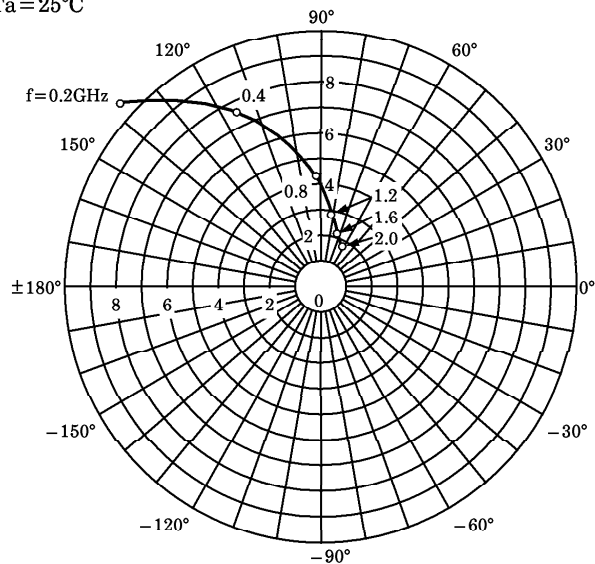
$V_{CE} = 10\text{V}$, $I_C = 20\text{mA}$

FREQUENCY		S11		S21		S12		S22	
MHz	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG	
200	0.645	−117.4	19.826	117.5	0.029	45.7	0.517	−47.9	
400	0.637	−150.2	11.127	100.3	0.037	46.1	0.334	−53.2	
600	0.643	−163.3	7.616	91.9	0.043	51.2	0.273	−54.3	
800	0.646	−171.5	5.780	86.7	0.050	56.4	0.247	−56.6	
1000	0.653	−177.7	4.629	82.0	0.057	60.7	0.237	−60.2	
1200	0.662	178.1	3.903	78.7	0.065	64.0	0.235	−64.2	
1400	0.668	174.2	3.399	75.0	0.073	66.8	0.237	−69.2	
1600	0.678	170.7	3.006	71.7	0.082	69.1	0.241	−74.1	
1800	0.679	167.5	2.711	68.7	0.091	71.1	0.248	−78.5	
2000	0.631	164.6	2.475	65.2	0.100	72.7	0.259	−83.1	

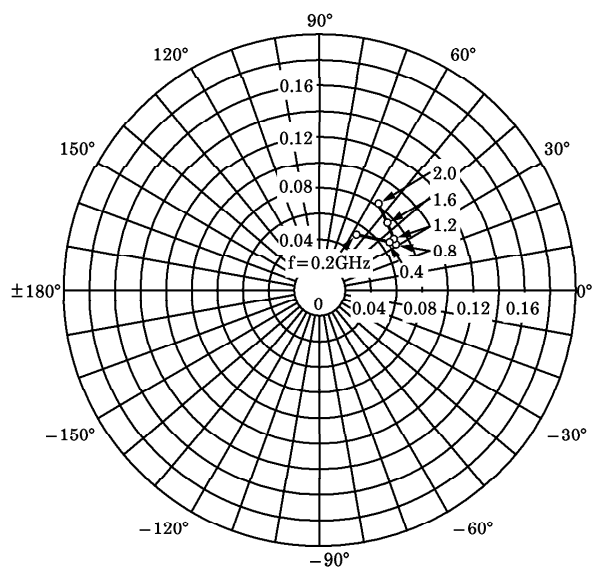
S_{11e}
 $V_{CE} = 10V$
 $I_C = 5mA$
 $T_a = 25^\circ C$
 (UNIT : Ω)



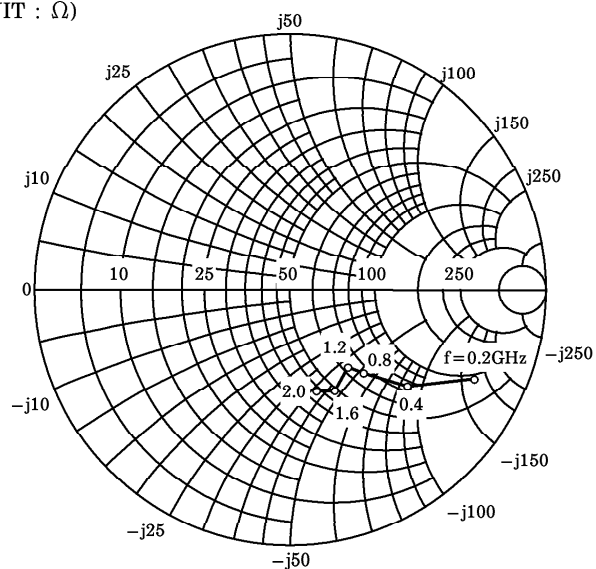
S_{21e}
 $V_{CE} = 10V$
 $I_C = 5mA$
 $T_a = 25^\circ C$



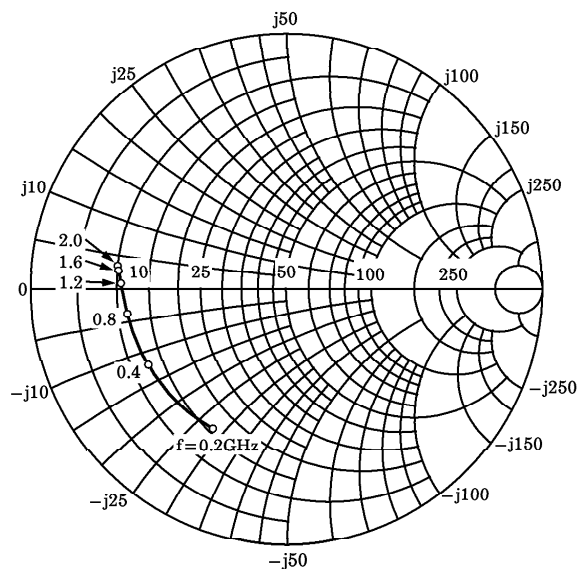
S_{12e}
 $V_{CE} = 10V$
 $I_C = 5mA$
 $T_a = 25^\circ C$



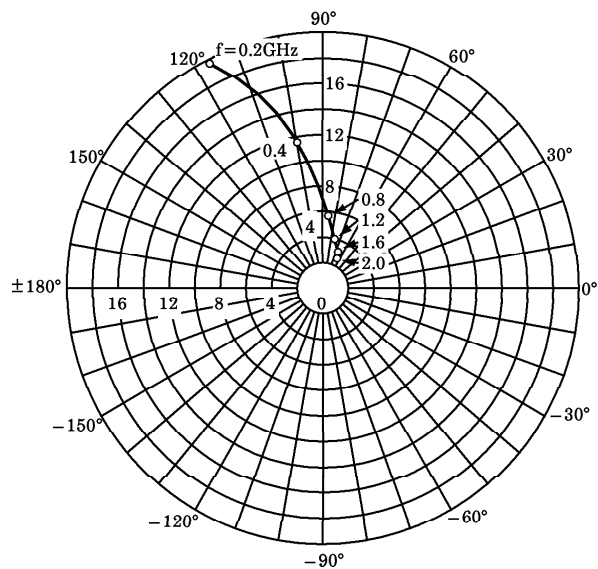
S_{22e}
 $V_{CE} = 10V$
 $I_C = 5mA$
 $T_a = 25^\circ C$
 (UNIT : Ω)



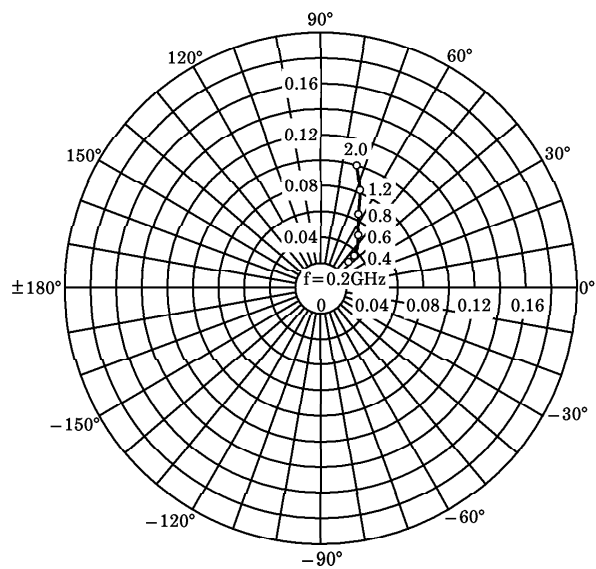
S_{11e}
 $V_{CE}=10V$
 $I_C=20mA$
 $T_a=25^\circ C$
 (UNIT : Ω)



S_{21e}
 $V_{CE}=10V$
 $I_C=20mA$
 $T_a=25^\circ C$



S_{12e}
 $V_{CE}=10V$
 $I_C=20mA$
 $T_a=25^\circ C$



S_{22e}
 $V_{CE}=10V$
 $I_C=20mA$
 $T_a=25^\circ C$
 (UNIT : Ω)

